

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

KIMURA, EIJI

U.S. Patent Application No. Not yet Assigned

Filed: *Herewith*

: Confirmation No.

: Group Art Unit:

: Examiner:

For: OPTICAL CHARACTERISTICS MEASURING APPARATUS, METHOD AND RECORDING MEDIUM

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

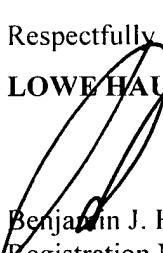
In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months after the U.S. filing date or before the mailing date of a first Office Action on the merits. No certification or fee is required.

The references were cited by or submitted to the U.S. Patent and Trademark Office in Parent Application No. 09/877,202, filed June 11, 2001, which is relied upon for an earlier filing date under 35 USC 120. Thus copies of these references are not attached. 37 CFR 1.98 (d).

Respectfully submitted,

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<b>INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)</b>			ATTY. DOCKET NO. <b>4468-017B</b>	U.S. PATENT APPLICATION NO.		
			<b>APPLICANT KIMURA, EIJI</b>			
			FILING DATE <b>Herewith</b>	GROUP		
<b>U.S. PATENT DOCUMENTS</b>						
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	<b>6,212,003</b>	<b>4/2001</b>	<b>Komazawa et al.</b>			
	<b>6,144,485</b>	<b>11/2000</b>	<b>Sugaya et al.</b>			
	<b>5,278,687</b>	<b>1/1994</b>	<b>Jannson et al.</b>			
	<b>4,997,277</b>	<b>3/1991</b>	<b>Horiguchi et al.</b>			
	<b>5,969,806</b>	<b>10/1999</b>	<b>Bergano</b>			
	<b>4,551,019</b>	<b>11/1985</b>	<b>Vella et al.</b>			
<b>FOREIGN PATENT DOCUMENTS</b>						
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation
						Yes
	<b>GB 2353591 A</b>	<b>2/2001</b>	<b>GB</b>			
	<b>0 348235</b>	<b>12/1989</b>	<b>EP</b>			
	<b>WO99/43054</b>	<b>8/1999</b>	<b>WIPO</b>			
<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>						
<b>EXAMINER</b>	<b>DATE CONSIDERED</b>					

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.